HALOGEN

FREE



Vishay Siliconix

# Complementary N- and P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY								
	V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)				
		$0.396$ at $V_{GS} = 4.5 \text{ V}$	0.5					
N-Channel	20	$0.456$ at $V_{GS} = 2.5 \text{ V}$	0.2	0.75 nC				
N-Channel	20	0.546 at V <sub>GS</sub> = 1.8 V	0.2	0.75 110				
		0.760 at V <sub>GS</sub> = 1.5 V	0.05					
		$0.756$ at $V_{GS} = -4.5 \text{ V}$	- 0.35					
P-Channel	- 20	1.038 at V <sub>GS</sub> = - 2.5 V	- 0.35	1 nC				
r-Gnannei	- 20	1.440 at V <sub>GS</sub> = - 1.8 V	- 0.1	1110				
		2.4 at V <sub>GS</sub> = - 1.5 V	- 0.05					

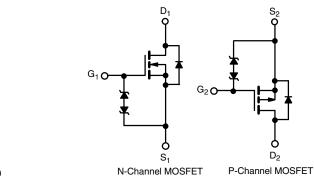
iriei	20	$0.546$ at $V_{GS} = 1.8 \text{ V}$	0.2	0.75110
		0.760 at V <sub>GS</sub> = 1.5 V	0.05	
		$0.756$ at $V_{GS} = -4.5 \text{ V}$	- 0.35	
nnel - 20	1.038 at $V_{GS} = -2.5 \text{ V}$	<sub>S</sub> = - 2.5 V - 0.35		
	1.440 at V <sub>GS</sub> = - 1.8 V	- 0.1	1 nC	
		2.4 at V <sub>GS</sub> = - 1.5 V	- 0.05	

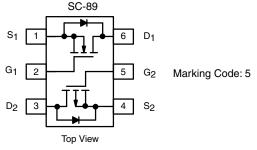
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFETs
- High-Side Switching
- Ease in Driving Switches
- Low Offset (Error) Voltage
- Low-Voltage Operation
- **High-Speed Circuits**
- Typical ESD Protection: N-Channel 1500 V P-Channel 1000 V (HBM)
- 100 % R<sub>a</sub> Tested
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

- Load Switch, Small Signal Switches and Level-Shift
  - Battery Operated Systems
  - Portable





SOT-563

Ordering Information: Si1016CX-T1-GE3 (Lead (Pb)-free and Halogen-free)

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25 °C, unless otherwise noted)							
Parameter		Symbol	N-Channel	P-Channel	Unit		
Drain-Source Voltage		$V_{DS}$	20	- 20	V		
Gate-Source Voltage		$V_{GS}$	±	V			
Continuous Drain Current /T 150 °C)	T <sub>A</sub> = 25 °C		0.6 <sup>a, b</sup>	- 0.6 <sup>a, b</sup>			
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 70 °C	'D	$I_{D} = \begin{array}{c c} 0.6^{a, b} & -0.6^{a, b} \\ \hline 0.49^{a, b} & -0.49^{a, b} \\ I_{DM} & 2 & -1.5 \end{array}$	Α			
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	2	- 1.5	A		
Source Drain Current Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	0.18 <sup>a, b</sup>	- 0.18 <sup>a, b</sup>			
Maximum Davian Dissination	T <sub>A</sub> = 25 °C	В	0.22 <sup>a, b</sup>	0.22 <sup>a, b</sup>	14/		
Maximum Power Dissipation	T <sub>A</sub> = 70 °C	- P <sub>D</sub>	0.14 <sup>a, b</sup>	0.14 <sup>a, b</sup>	W		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150				
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>			260		°C		

THERMAL RESISTANCE RATINGS									
N-Channel P-Channel									
Parameter		Symbol	Тур.	Max.	Тур.	Max.	Unit		
Maximum Junction-to-Ambient <sup>a, c</sup>	t ≤ 5 s	R <sub>thJA</sub>	470	565	470	565	°C/W		
Maximum Junction-to-Ambient	Steady State	' 'thJA	560	675	560	675	O/ VV		

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 5 s.
- c. Maximum under steady state conditions is 675 °C/W.

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<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 $^{\circ}$	C, unless oth	erwise noted)						
Parameter	Symbol Test Conditions			Min.	Тур.	Max.	Unit	
Static								
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	N-Ch	20			V	
Dialii-Source Breakdown Voltage	V DS	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	P-Ch	- 20			v	
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA	N-Ch		17			
VDS Temperature element	∆v DS/1J	I <sub>D</sub> = - 250 μA	P-Ch		- 12		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	N-Ch		- 1.8		,	
*GS(in) remperature decimelent	2 • GS(tn)/ • J	I <sub>D</sub> = - 250 μA	P-Ch		1.8			
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	N-Ch	0.4		1	V	
	- GS(III)	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	P-Ch	- 0.4		- 1	-	
		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$	N-Ch			± 1		
Gate-Source Leakage	I <sub>GSS</sub>	- D3 - 1, 1G3 - 111 1	P-Ch			± 1		
	433	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	N-Ch			± 30		
			P-Ch			± 30	μΑ	
		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	N-Ch			1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V	P-Ch			- 1		
	D33	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	N-Ch			10		
		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	P-Ch			- 10		
On-State Drain Current <sup>b</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	N-Ch	2			Α	
	B(GII)	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	P-Ch	- 1.5				
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 0.5 A	N-Ch		0.330	0.396		
		V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 0.35 A	P-Ch		0.630	0.756		
		$V_{GS} = 2.5 \text{ V}, I_D = 0.2 \text{ A}$	N-Ch		0.380	0.456	Ω	
Drain-Source On-State Resistance <sup>b</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 2.5 V, I <sub>D</sub> = - 0.35 A	P-Ch		0.865	1.038		
		V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 0.2 A	N-Ch		0.420	0.546		
		V <sub>GS</sub> = - 1.8 V, I <sub>D</sub> = - 0.1 A	P-Ch N-Ch		1.2	1.44		
		$V_{GS} = 1.5 \text{ V}, I_D = 0.05 \text{ A}$			0.505	0.760		
		V <sub>GS</sub> = - 1.5 V, I <sub>D</sub> = - 0.05 A	P-Ch		1.6	2.4		
Forward Transconductance <sup>b</sup>	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_D = 0.5 \text{ A}$	N-Ch		2		S	
		V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 3.6 A	P-Ch		1			
Input Capacitance	C <sub>iss</sub>	N Channel	N-Ch		43			
		N-Channel $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	P-Ch		45			
Output Capacitance	C <sub>oss</sub>	VDS = 10 V, VGS = 0 V, I = 1 IIII 12	N-Ch P-Ch		14		pF	
		P-Channel V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz			15		'    -	
Reverse Transfer Capacitance	C <sub>rss</sub>				8			
D! - 3			P-Ch		10			
Dynamic <sup>a</sup>		101/1/ 451/1 004	L NI OI:	I	1 40	I 0		
		$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 0.6 \text{ A}$	N-Ch P-Ch		1.3	2		
Total Gate Charge	$Q_g$	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -0.4 \text{ A}$			1.65	2.50	<u> </u>	
	9	N Channel	N-Ch		0.75	1.2		
	N-Channel V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 2.5 V, I <sub>I</sub>		P-Ch		1	2	nC	
Gate-Source Charge	$Q_{gs}$	D3 15 1, 103 215 1, 10 516 N	N-Ch		0.15			
	95	P-Channel	P-Ch		0.2			
Gate-Drain Charge	$Q_{gd}$	$V_{DS} = -10 \text{ V}, V_{GS} = -2.5 \text{ V}, I_{D} = -0.4 \text{ A}$	N-Ch		0.13		4	
<u>-</u>	3~		P-Ch	0.1	0.26	04.4		
Gate Resistance	$R_{g}$	f = 1 MHz	N-Ch	2.4	12.2	24.4	Ω	
	9		P-Ch	2.4	12	24		

#### Notes:

a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.



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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Dynamic <sup>a</sup>	•				•		
Turn-On Delay Time	t <sub>d(on)</sub>		N-Ch		11	20	
	-u(on)	N-Channel $V_{DD} = 10 \text{ V, R}_{L} = 20 \Omega$	P-Ch		9	18	
Rise Time	t <sub>r</sub>	$V_{DD} = 10 \text{ V}, N_L = 20 \Omega$ $I_D \approx 0.5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$	N-Ch		16	24	
	'	D = 0.0 7 % • GEN 0 5, 1.1g	P-Ch		10	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	P-Channel	N-Ch		26	39	
-	4(0)	$V_{DD} = -10 \text{ V}, R_L = 33.3 \Omega$	P-Ch		10	20	
Fall Time	t <sub>f</sub>	$I_D \cong$ - 0.3 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$	N-Ch		11	20	
			P-Ch N-Ch		8	16 4	ns
Turn-On Delay Time	t <sub>d(on)</sub>	N-Channel	P-Ch		1	2	4
Rise Time		$V_{DD} = 10 \text{ V, R}_{L} = 20 \Omega$	N-Ch		13	20	
	t <sub>r</sub>	$I_D \cong 0.5 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$	P-Ch		8	16	
Turn-Off Delay Time		-	N-Ch		7	14	- - -
	t <sub>d(off)</sub>	P-Channel $V_{DD} = -10 \text{ V}, R_L = 33.3 \Omega$	P-Ch		9	18	
		$I_D \cong -0.3 \text{ A}, V_{GEN} = -8 \text{ V}, R_q = 1 \Omega$	N-Ch		5	10	
Fall Time	t <sub>f</sub>				5	10	
Drain-Source Body Diode Characterist	ics			l.	•		ı
Pulse Diode Forward Current <sup>a</sup>	1					2	Α
Tuise blode Forward Current	I <sub>SM</sub>		P-Ch			- 1.5	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 0.5 A, V <sub>GS</sub> = 0 V	N-Ch		0.85	1.2	V
Body Blode Voltage	V SD	I <sub>S</sub> = - 0.3 A, V <sub>GS</sub> = 0 V	P-Ch		- 0.87	- 1.2	v
Body Diode Reverse Recovery Time	t <sub>rr</sub>		N-Ch		10	20	ns
Body Blodd Hevered Headvery Time	भा	1	P-Ch		16	24	
Body Diode Reverse Recovery Charge	$Q_{rr}$	N-Channel $I_F = 0.5 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ , $T_J = 25 ^{\circ}\text{C}$	N-Ch		2	4	nC
	11		P-Ch		8	20	
Reverse Recovery Fall Time	ta	P-Channel	N-Ch		5		ns
•	u	$I_F = -0.3 \text{ A}, \text{ dI/dt} = -100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	P-Ch		11		
Reverse Recovery Rise Time	t <sub>b</sub>		N-Ch		5		
•	~		P-Ch		5		<u> </u>

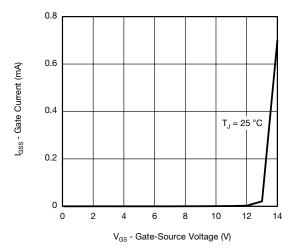
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Guaranteed by design, not subject to production testing.

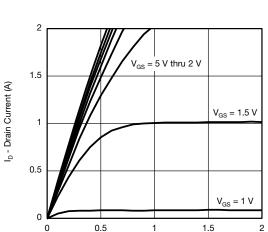
b. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.

# Vishay Siliconix

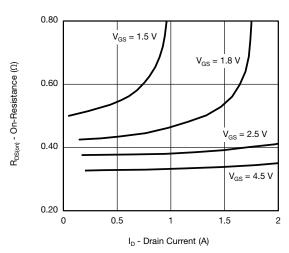
## N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



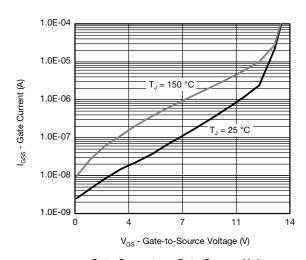
Gate Current vs. Gate-Source Voltage



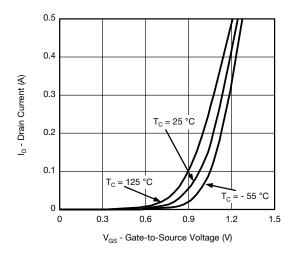
V<sub>DS</sub> - Drain-to-Source Voltage (V) **Output Characteristics** 



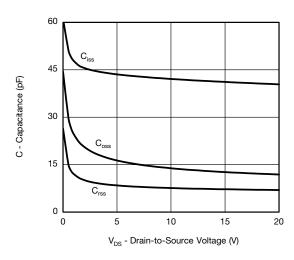
On-Resistance vs. Drain Current



Gate Current vs. Gate-Source Voltage



**Transfer Characteristics** 

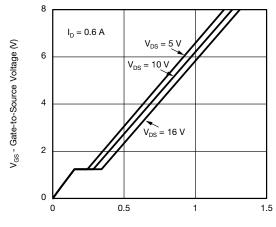


Capacitance



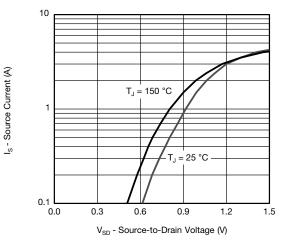
# Vishay Siliconix

## N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

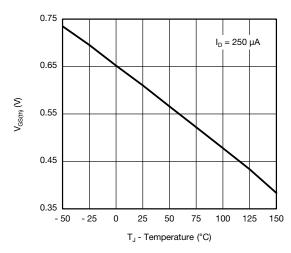


Q<sub>g</sub> - Total Gate Charge (nC)

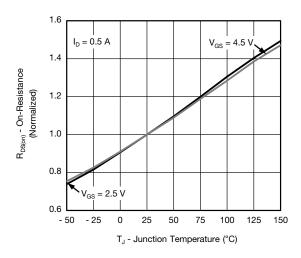
#### Gate Charge



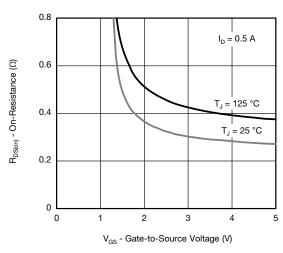
Soure-Drain Diode Forward Voltage



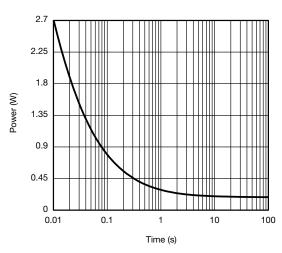
**Threshold Voltage** 



On-Resistance vs. Junction Temperature



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

0.24

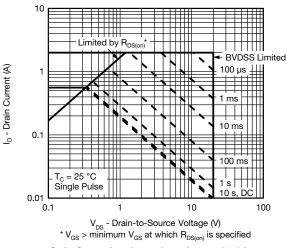
0.18

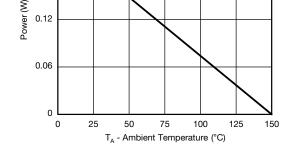
# **Si1016CX**

# Vishay Siliconix

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# N-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

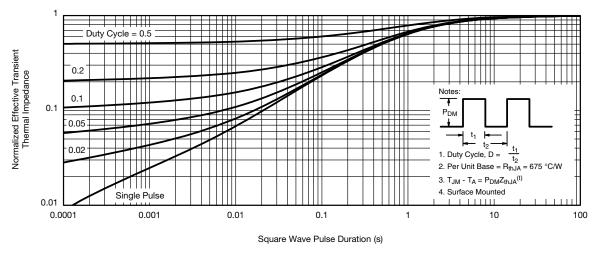




Safe Operating Area, Junction-to-Ambient

Power Derating, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



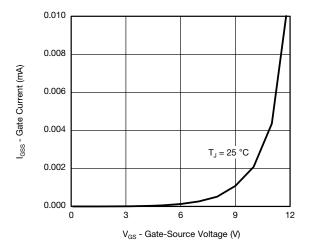
Normalized Thermal Transient Impedance, Junction-to-Ambient

1.E-04

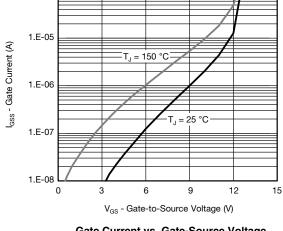


# Vishay Siliconix

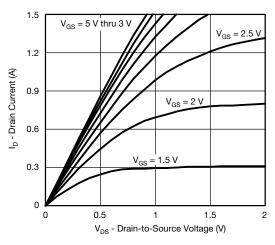
### P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



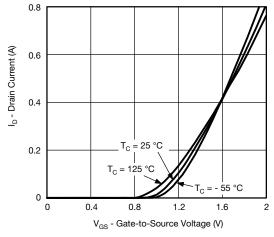
#### Gate Current vs. Gate-Source Voltage



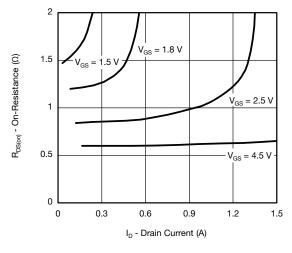
Gate Current vs. Gate-Source Voltage



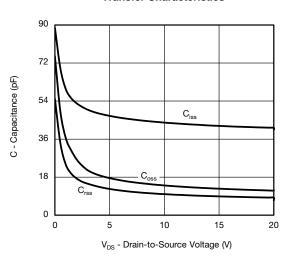
**Output Characteristics** 



**Transfer Characteristics** 



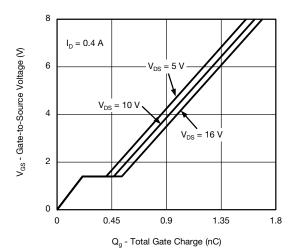
On-Resistance vs. Drain Current



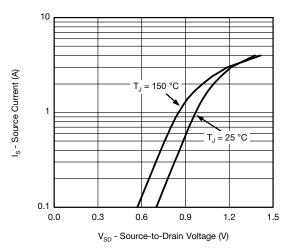
Capacitance

# Vishay Siliconix

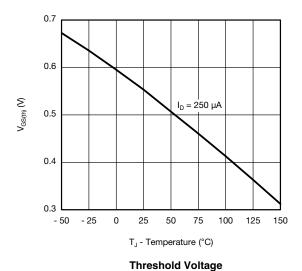
# P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

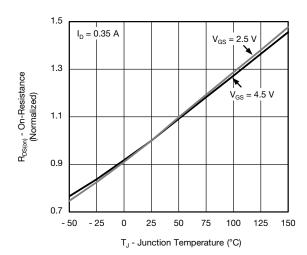


#### **Gate Charge**

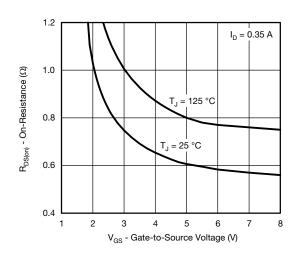


#### Soure-Drain Diode Forward Voltage

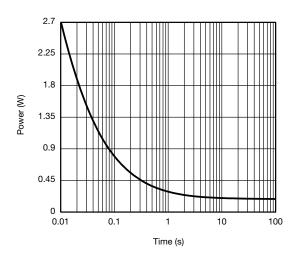




#### On-Resistance vs. Junction Temperature



#### On-Resistance vs. Gate-to-Source Voltage

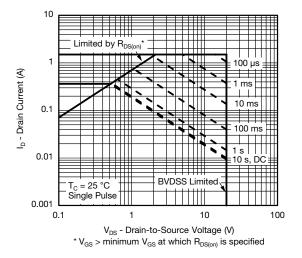


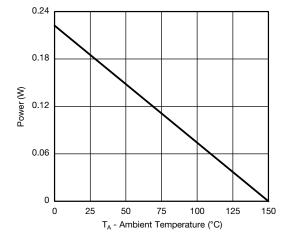
Single Pulse Power, Junction-to-Ambient



Vishay Siliconix

#### P-CHANNEL TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

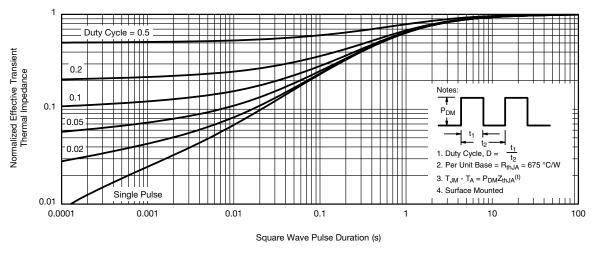




Safe Operating Area, Junction-to-Ambient

Power Derating, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

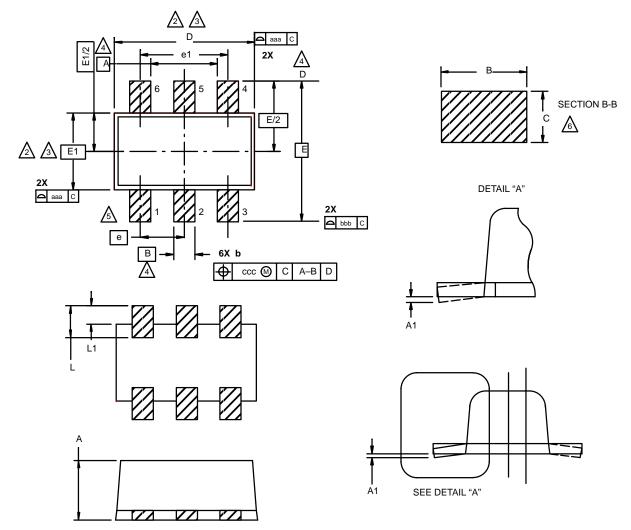


Normalized Thermal Transient Impedance, Junction-to-Ambient

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?67535.



#### SC89: 6- LEADS (SOT-563F)



#### NOTES:

1. Dimensions in millimeters.



Dimension D does not include mold flash, protrusions or gate burrs. Mold flush, protrusions or gate burrs shall not exceed 0.15 mm per dimension E1 does not include interlead flash or protrusion, interlead flash or protrusion shall not exceed 0.15 mm per side.



Dimensions D and E1 are determined at the outmost extremes of the plastic body exclusive of mold flash, the bar burrs, gate burrs and interlead flash, but including any mismatch between the top and the bottom of the plastic body.



Datums A, B and D to be determined 0.10 mm from the lead tip.



Terminal numbers are shown for reference only.



These dimensions apply to the flat section of the lead between 0.08 mm and 0.15 mm from the lead tip.

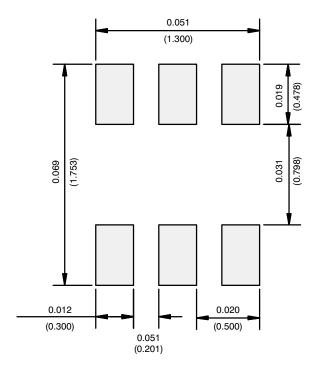
	MILLIM	IETERS			Tolerances		
Dim	Min	Max	Note	Symbol	Of Form And Position		
Α	0.56	0.60		aaa	0.10		
A1	0.00	0.10		bbb	0.10		
b	0.15	0.30		ccc	0.10		
С	0.10	0.18					
D	1.50	1.70	2, 3				
E	1.55	1.70					
E1	1 1.20 BSC		2, 3				
е	0.50	BSC					
e1	1.00	1.00 BSC					
L	0.35 BSC						
L1	0.20 BSC						
ECN: E-00499—Rev. B, 02-Jul-01							

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DWG: 5880



### **RECOMMENDED MINIMUM PADS FOR SC-89: 6-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)

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APPLICATION NOTE



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